Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/896,255	HSU ET AL.	
Examiner	Art Unit	
Flien C. Tran	2134	

	SEARCHED		
Class	Subclass	Date	Examiner
713	189	1/20/2006	ECT
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		-	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	1/20/2006	ECT